

Notice of References Cited	Application/Control No. 10/568,786	Applicant(s)/Patent Under Reexamination UCHIDA ET AL.	
	Examiner Xinning(Tom) Niu	Art Unit 2828	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0252739	12-2004	Takeuchi et al.	372/046
	B	US-			
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

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